

**• General Description**

The CH20P04A combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ . This device is ideal for load switch and battery protection applications.

**• Features**

- Advance high cell density Trench technology
- Low  $R_{DS(ON)}$  to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

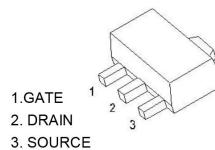
**• Application**

- MB/VGA Vcore
- SMPS 2<sup>nd</sup> Synchronous Rectifier
- POL application
- BLDC Motor driver

**• Product Summary**

$V_{DS} = -40V$   
 $I_D = -20A$   
 $R_{DS(ON)} \text{ Typ} = 26 \text{ m}\Omega$   
 $\text{@ } V_{GS} = -10V$

SOT-89-3L


**• Ordering Information:**

Part NO.	CH20P04A
Marking	CH20P04A
Packing Information	REEL TAPE
Basic ordering unit (pcs)	1000

**• Absolute Maximum Ratings (  $T_c = 25^\circ\text{C}$  )**

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	$V_{DS}$	-40	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current	$I_D@T_c=25^\circ\text{C}$	-20	A
	$I_D@T_c=75^\circ\text{C}$	-10	A
	$I_D@T_c=100^\circ\text{C}$	-8	A
Pulsed Drain Current <sup>①</sup>	$I_{DM}$	-40	A
Total Power Dissipation	$P_D@T_c=25^\circ\text{C}$	4.6	W
Total Power Dissipation	$P_D@T_a=25^\circ\text{C}$	1.5	W
Operating Junction Temperature	$T_J$	-55 to 150	$^\circ\text{C}$
Storage Temperature	$T_{STG}$	-55 to 150	$^\circ\text{C}$
Single Pulse Avalanche Energy	$E_{AS}$	160	mJ

**•Thermal resistance**

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R <sub>thJC</sub>	-	-	2.3	°C/W
Thermal resistance, junction - ambient	R <sub>thJA</sub>	-	-	27	°C/W
Soldering temperature, wavesoldering for 10s	T <sub>sold</sub>	-	-	265	°C

**•Electronic Characteristics**

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =-250uA	-40			V
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =-250uA	-1.0	-1.7	-2.5	V
Drain-Source Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> =-40V, V <sub>GS</sub> =0V			-1.0	uA
Gate- Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V ,V <sub>DS</sub> =0V			±100	nA
Static Drain-source On Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =-10V, I <sub>D</sub> =-5A		26	34	mΩ
		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-3A		34	46	mΩ
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> =-10V, I <sub>D</sub> =-5A		10		s
Source-drain voltage	V <sub>SD</sub>	I <sub>S</sub> =-5A			1.28	V

**•Electronic Characteristics**

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Input capacitance	C <sub>iss</sub>	f = 1MHz	-	1834	-	pF
Output capacitance	C <sub>oss</sub>		-	157	-	
Reverse transfer capacitance	C <sub>rss</sub>		-	89.5	-	

**•Gate Charge characteristics(T<sub>a</sub> = 25°C)**

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Total gate charge	Q <sub>g</sub>	V <sub>DD</sub> =-20V I <sub>D</sub> =-5A V <sub>GS</sub> =-10V	-	22	-	nC
Gate - Source charge	Q <sub>gs</sub>		-	4.5	-	
Gate - Drain charge	Q <sub>gd</sub>		-	3.8	-	

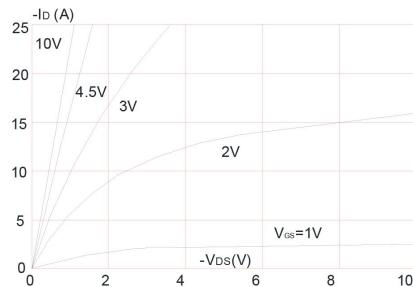
Notes:1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature

2. EAS condition: T<sub>J</sub>= 25°C, V<sub>DD</sub> = -20V, V<sub>G</sub>= -10V, L=0.5mH, R<sub>G</sub>= 25Ω, I<sub>AS</sub>= -10A

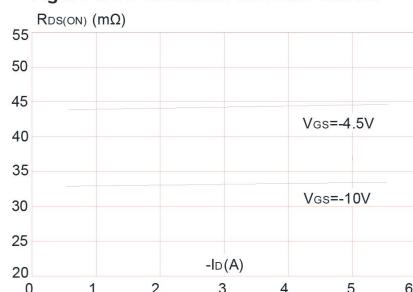
3. Pulse Test: Pulse Width≤300μs, Duty Cycle≤2%

## Typical Performance Characteristics

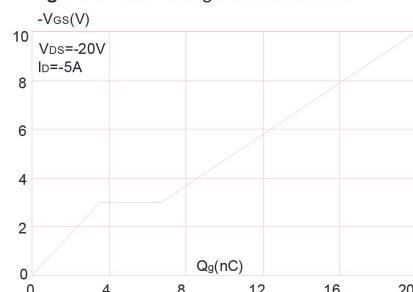
**Figure 1:** Output Characteristics



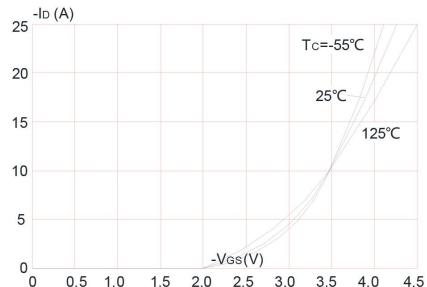
**Figure 3:** On-resistance vs. Drain Current



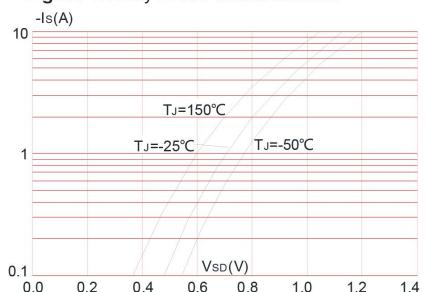
**Figure 5:** Gate Charge Characteristics



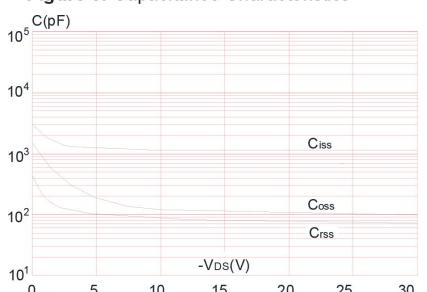
**Figure 2:** Typical Transfer Characteristics



**Figure 4:** Body Diode Characteristics

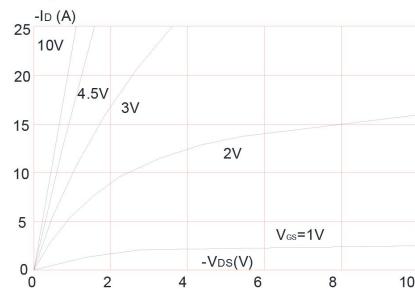


**Figure 6:** Capacitance Characteristics

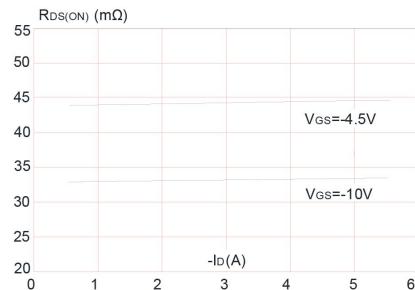


### Typical Performance Characteristics

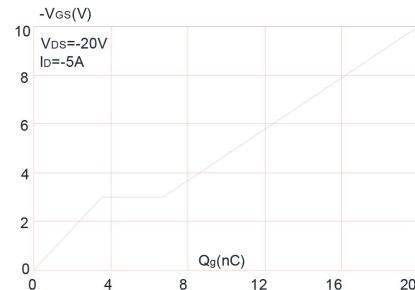
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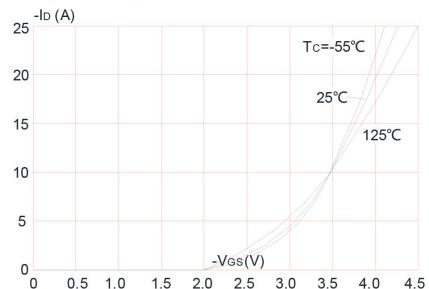
**Figure 3:** On-resistance vs. Drain Current



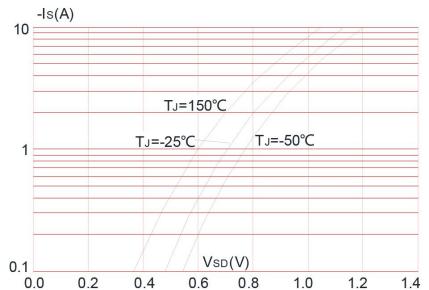
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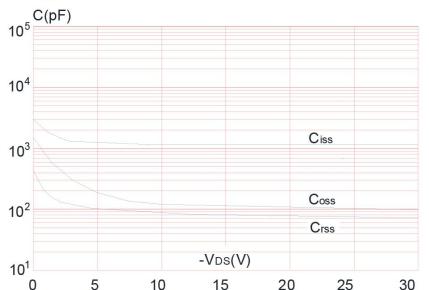
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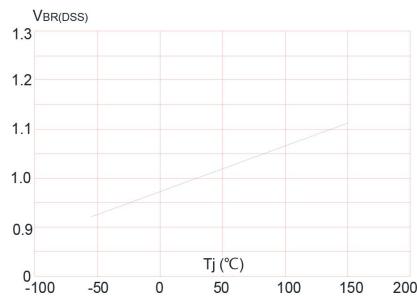
**Figure 4:** Body Diode Characteristics



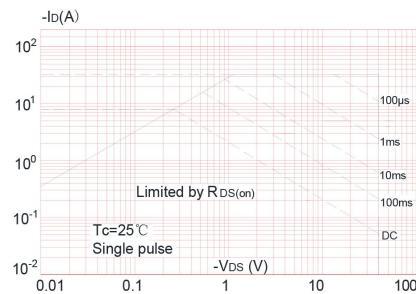
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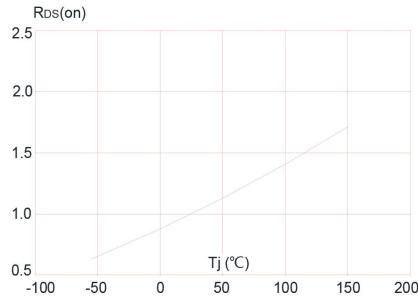
**Figure 7:** Normalized Breakdown Voltage vs. Junction Temperature



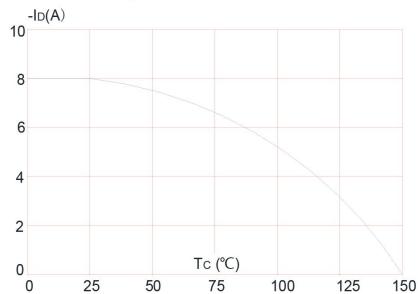
**Figure 9:** Maximum Safe Operating Area



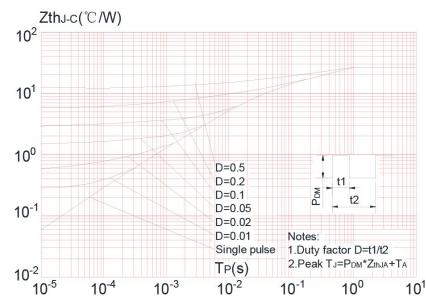
**Figure 8:** Normalized on Resistance vs. Junction Temperature

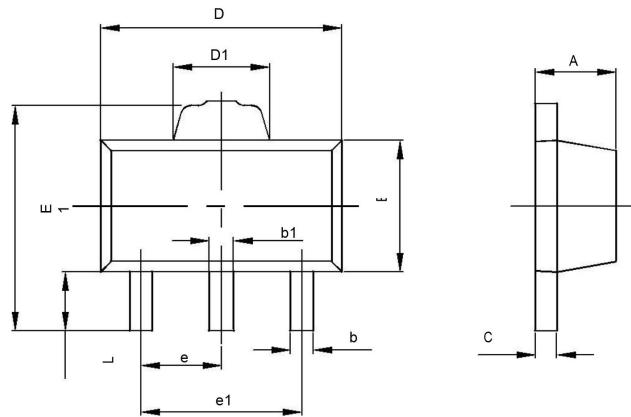


**Figure 10:** Maximum Continuous Drain Current vs. Case Temperature



**Figure 11:** Maximum Effective Transient Thermal Impedance, Junction-to-Case



**SOT-89-3L PACKAGE OUTLINE DIMENSIONS**


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.400	1.600	0.055	0.063
b	0.320	0.520	0.013	0.020
b1	0.360	0.560	0.014	0.022
c	0.350	0.440	0.014	0.017
D	4.400	4.600	0.173	0.181
D1	1.400	1.800	0.055	0.071
E	2.300	2.600	0.091	0.102
E1	3.940	4.250	0.155	0.167
e	1.500TYP		0.060TYP	
e1	2.900	3.100	0.114	0.122
L	0.900	1.100	0.035	0.043